Application/Control No. 09/774,930 Examiner M. Lee Applicant(s)/Patent Under Reexamination BASSON ET AL. Art Unit Page 1 of 1

Notice of References Cited

U.S. PATENT DOCUMENTS Document Number Date Name Classification Country Code-Number-Kind Code MM-YYYY 08-1999 You et al. 348/468 US-5,946,046 Α Beadles et al. 345/8 В US-5,648,789 07-1997 348/465 С US-6,456,331 09-2002 Kwoh, Daniel S. 348/468 08-1996 Chang, Wen F. D US-5,543,851 Ε US-US-US-G US-Н ١ US-US-J US-Κ

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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